Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/523,874	LEE ET AL.	
Examiner	Art Unit	
Jafar Parsa	1621	

SEARCHED					
Class	Subclass	Date	Examiner		
562	412	1/16/2006	JP		
562	416	1/16/2006	JP		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East, West and STN	1/16/2006	JP		
inventor name search	1/16/2006	JP		
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